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The effect of annealing on magnetic properties of Co/Gd multilayers

S. Vorobiov\textsuperscript{a}, Ia. Lytvynenko\textsuperscript{a,*}, T. Hauet\textsuperscript{b}, M. Hehn\textsuperscript{b}, D. Derecha\textsuperscript{c}, A. Chornous\textsuperscript{a}

\textsuperscript{a} Sumy State University, Rymskogo-Korsakova 2, 40007 Sumy, Ukraine

\textsuperscript{b} Institut Jean Lamour, UMR CNRS 7198, Université de Lorraine, 54506 Vandoeuvre-les-Nancy, France

\textsuperscript{c} Institute of Magnetism NAS and MOE of Ukraine, Akad. Vernadskogo 36-b, 03142 Kyiv, Ukraine

Abstract

The impact of annealing on the structural and magnetic properties of sputtered [Gd/Co]\textsubscript{n} multilayers has been researched. Structural and phase contrast of atomic force microscope measurements at the imaging of the facet sample cross-section demonstrate that thermal annealing process at 700 K leads to intermixing between Co and Gd layers, i.e. the alloy formation around the former interface. Magnetometry measurements are coherent with such CoGd alloying. Annealing reinforces the domination of domain wall propagation in the magnetization reversal mechanism. Low temperature magnetometry analysis seems to indicate that CoGd mixing due to annealing may occurs over 2 nm apart from initial Co/Gd interface.

Keywords: multilayers, annealing, interface alloying, magnetization, coercivity.

Rare Earths (REs) – Transition Metals (TMs) ferrimagnetic alloys or multilayers have a great importance in modern magnetism because of their unique properties due to their 4f orbitals: perpendicular magnetic anisotropy [1-3], antiferromagnetic exchange-
coupling in multilayers or alloys with both REs and TMs [4-5] and frozen frustrated magnetic state [6]. The variation of RE/TM concentration allows controlling the magnetic and magnetotransport properties of the system, as well as alignment of its magnetic moment with the external magnetic field [1-3] or inverse GMR [7]. Magnetic multilayers, like Co/Gd, Co/Tb, Co/Dy or Co/Ho have been recently used as model systems to study the intrinsic mechanism of circularly polarized light induced switching [8].

Despite a very active research of REs - TMs systems, many things are still unclear especially in multilayers. Indeed, the properties of RE/TM multilayers have been widely studied in the past [4-5, 9-11] but the influence of heat treatment on the magnetic behavior of multilayers has not been enough researched. It has also been shown that interfacial magnetic disorder [12] impacts the magnetism and affects to the magnetization reversal processes [13]. In this article, we report experimental researches of the magnetic properties in Gd/Co multilayers with various Co layer thicknesses and [Gd/Co] repeats number and the effect of thermal annealing on those properties. Lateral AFM measurements and magnetometry measurements demonstrate that a 700 K annealing leads to an inter-diffusion over more than 2 nm apart from the interface.

Si/SiO/Ta(5nm)/Pt(5nm)/[Co(x)/Gd(2nm)]n/Ta(2nm)/Pt(5nm) and Si/SiO/Ta(5nm)/Pt(5nm)/Co(3.5nm)/Gd(7nm))/Co(3.5nm)/Ta(2nm)/Pt(5nm) multilayers were grown by sputtering at room temperature under a pressure of 5×10⁻³ mbar of Ar in a UHV chamber with base pressure less than 5×10⁻⁹ mbar. The Co layer thicknesses (x) were chosen equal to 2 or 5 nm. The number of Co/Gd bilayer repeats (n) was varied from 2 to 8. A SiO(100nm)/Ta(5nm)/Pt(5nm) buffer layer was used to prevent mixing of Si with the multilayer stack during annealing procedure. The multilayers were capped with
Ta(2nm)/Pt(5nm) bilayer to protect them from oxidation. After deposition, the multilayers were either annealed in high vacuum chamber at 700 K for 20 minutes or kept without thermal treatment. The X-ray diffraction (XRD) was used for the research of samples phase state before annealing. The study of structural changes due to annealing has been performed using AFM (NT-MDT Solver Pro MFM) imaging on cross-section of the facet sample, as a result of semi-contact two-pass scanning. A cross-section was done at small angle to the sample plane (10-12°). As a result we have got much bigger area of the researched sample. Both the structural and phase contrast microscopy of the multilayer were performed in order to obtain more detailed information about the samples structure. Magnetic characterizations were performed at 300 K and 10 K using both a commercial vibrating sample magnetometer (VSM) and a commercial SQUID-VSM.

A phase composition studying by means of X-ray diffraction showed that the as-deposited multilayers consist of the hcp-Co + fcc-Co + quasi amorphous Gd. Quasi-amorphous state of Gd is characterized by the existence only the nearest crystalline order or by the beginning of crystallization process in Gd layer which is confirmed by the presence only so called “halo” on the electron diffraction patterns and absence the clear rings on it which we showed in our previous works for Gd and Co/Gd/Co system [14-16] that also has a good agreement with literature data [23-25]. As a first step in the specification of the influence of the 700 K annealing process on Co/Gd interfaces was defined if the layered structure of the samples has been maintained. In Fig. 1 the AFM phase contrast cross-section image of Co(3.5nm)/Gd(7nm)/Co(3.5nm) sample demonstrates presence of interlayers between Gd and Co after annealing. Annealing causes a phase transition hcp-Co → fcc-Co at 700 K and consequently the
recrystallization process with Co grains size growth which led to the interface morphology changes and penetration of Co into Gd layer and vice versa - Co and Gd are mixing. As Co and Gd are not soluble in each other in the solid state we can conclude that theoretically we received a mechanically mixed alloy of crystalline Co and amorphous Gd. Very similar results were observed by authors [17-19] as for intermixing between Co and Gd layers with amorphous CoGd alloy formation. The substantial aliquot deviation between the measured and declared layers on Fig.1 can be explained by the peculiarities of the measurement and sample preparation technics (the mutual orientation between facet sample and cantilever and the non-perpendicularity of the cross-section). Figure 2 shows magnetization curves of \([\text{Co}(5 \text{ nm})/\text{Gd}(2 \text{ nm})]_n\) multilayers with different numbers of repeats (n=2; 4; 6; 8) before (a) and after (b) annealing measured under in-plane applied magnetic field. The influence of repeats number on coercive field (\(H_C\)) of non-annealed samples is weak (Fig. 2 (a)). First of all, after thermal anneal, \(H_C\) for both \([\text{Co}(5 \text{ nm})/\text{Gd}(2 \text{ nm})]_n\) and \([\text{Co}(2 \text{ nm})/\text{Gd}(2 \text{ nm})]_n\) increases. Secondly, it increases and varies linearly with the number of repeats as shown in Fig. 2 (b, c). One of the possible reasons for such behavior is the increase of interface roughness with annealing that affects the domain walls propagation and therefore \(H_C\). The impact of interface diffusion would increase with the number of interface, i.e. with the number of repeats.

To confirm the role of domain wall motion in the magnetization reversal mechanism in Co/Gd multilayers, we measured coercivity as a function of external magnetic field angle. In Fig. 3, the coercivity is found to drastically increase as the field angle approaches 90° (0° being a direction in the film plane and 90° the direction perpendicular to the film). Such behavior is typical for materials with in-plane
anisotropy and for magnetization reversal process that is dominated by domain wall propagation [20]. The same behavior is found to be similar for all samples whatever the repeats number is. One can notice that the increase close to 90° is much larger for annealed sample. Moreover one can notice that this increase is also much larger for n=8 sample (Fig. 3 (b)) as compared to the n=2 sample (Fig.3 (a)). So it seems that indeed the domain wall propagation influence is enhanced by the annealing process and that the number of repeats matters. It confirms that most probably the coercivity increasing along with the increasing of repeats number connects with alloying formation on Co/Gd interface that creates the pinning center for domain wall.

To further confirm the intermixing at the Co/Gd interface during annealing, we focused on [Co(2)/Gd(2)]₄. The normalized magnetization versus field loop recorded at 300 K and 10 K are shown in Fig. 4. As seen in Fig. 4 (a), at 300 K, single hysteresis loop is observed for non-annealed [Co(2)/Gd(2)]₄. At room temperature, bulk Gd is paramagnetic because of its low Curie temperature (292 K). Nevertheless, one has to notice that stabilization of ferromagnetism in Gd for temperature up to 350 K has already been reported and explained by the exchange coupling at the interface with Co [10-11]. In our case, Fig. 4 (a) does not reveal any exchange coupling features at 300 K. At low temperature (10 K) the hysteresis loop shape for non-annealed sample is more complex (Fig. 4 (a)). At this temperature Gd is expected to be ferromagnetic with the bulk saturation magnetization $M_{\text{Gd}} = 2056 \text{ emu/cm}^3$, while $M_{\text{Co}}$ is 1400 emu/cm³.

The 10 K hysteresis loops are typical for antiferromagnetic interface exchange coupling between Co and Gd [6]. At zero field, $M_{\text{Gd}}$ being larger than $M_{\text{Co}}$, Gd moments align to the field while Co align is antiparallel to it due to anti-ferromagnetic exchange coupling. When the field amplitude is increased, the competition between Zeeman
energy and interface exchange coupling leads to a slow monotonous rotation of Co moments along the magnetic field direction. The total magnetization increases.

After annealing, although the single reversal at 300 K remains, magnetization versus field loop at 10 K has strongly changed. Indeed no plateau is observed at remanence (Fig. 4 (b)). Only single reversal occurs which Co/Gd multilayers have been changed into a single CoGd alloy through the annealing process. The fact that saturation is reached only around 2 Tesla can be related to either a reminiscent CoGd pure layer in a Co/GdCo/Gd stacking or due to amorphous alloy random anisotropy.

One can calculate the expected concentration of the CoGd alloy that is created at the Co/Cd interface during annealing using equation (1) and assuming that the alloying occurs within the same thickness on both side of the interface [21]:

\[ c_{Co} = \frac{D_{Co}d_{Co}\mu_{Co}^{-1}}{D_{Co}d_{Co}\mu_{Co}^{-1} + D_{Gd}d_{Gd}\mu_{Gd}^{-1}} \]  

where \( D \) corresponds to density, \( \mu \) – to molar mass of elements and \( d \) – to effective film thickness for each layer.

The concentration of Co is found to be 75% if [Co(2)/Gd(2)]\(_4\) transforms into alloy. Hence, the present alloy Gd\(_{25}\)Co\(_{75}\) is Gd-dominant and the net magnetization is parallel to the Gd sublattice since the compensation composition (\( M_{alloy} = 0 \)) of Gd in Gd\(_x\)Co\(_{1-x}\) alloy is 20% at 5 K [1, 22]. Inside the alloy Co moments reversal along the field would require 10 Tesla that is way it does not appears in Fig. 4 (b).

In summary, magnetization of [Gd/Co]\(_n\) multilayers before and after annealing at 700 K were studied. AFM measurements demonstrate that annealing leads to
intermixing between Co and Gd layers, i.e. the formation of the amorphous alloy around the former interface. Magnetometry measurements show that domain wall propagation is dominated at the reversal process. Co/Gd interface alloying due to annealing causes pinning against domain wall motion and the coercivity increase is proportional to the number of interface in the initial multilayer stack. Low temperature magnetometry analysis seems to indicate that CoGd mixing due to annealing may occur over 2 nm apart from initial Co/Gd interface.

Acknowledgments

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References


**Fig.1.** AFM phase contrast image of the cross-section of Co (3.5 nm) / Gd (7 nm) / Co (3.5 nm) three-layer sample on the amorphous glass-ceramic substrate after annealing at 700 K
Fig. 2. Normalized magnetization as a function of magnetic field, applied in the film plane for the [Co(5 nm)/Gd(2 nm)]$_n$ multilayers measured at room temperature before (a) and after (b) annealing. (c) Coercivity as a function of repeats number of [Co(x)/Gd(2 nm)] stack in multilayers measured at room temperature before and after annealing.

Fig. 3. Coercivity as a function of angle for [Co(5 nm)/Gd(2 nm)]$_2$ (a) and [Co(5 nm)/Gd(2 nm)]$_8$ (b) multilayers before and after annealing at 700 K.

Fig. 4. Normalized magnetization as a function of magnetic field applied in-plane, measured for [Co(2 nm)/Gd(2 nm)]$_4$ system at 300 K and 10 K for samples before (a) and after annealing (b).
Fig. 1.
Fig. 2.
Fig. 3.

Fig. 4.